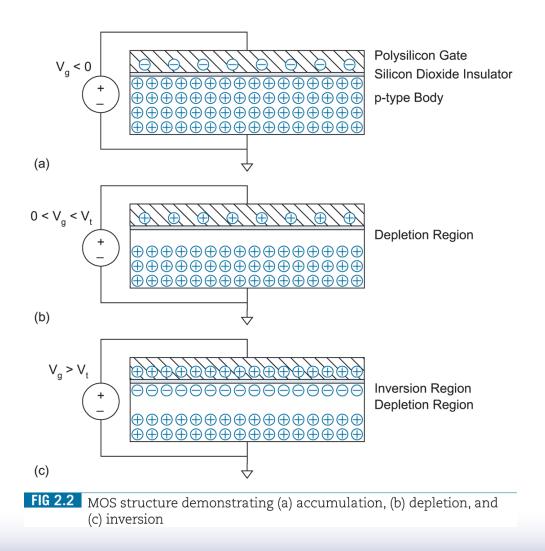


ECE 122A VLSI Principles Lecture 7

Prof. Kaustav Banerjee Electrical and Computer Engineering University of California, Santa Barbara *E-mail: kaustav@ece.ucsb.edu*

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MOS Capacitor (Review)

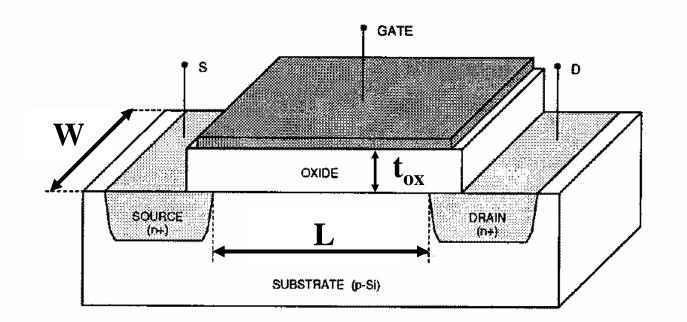


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MOS Transistor

Important transistor physical characteristics

- Channel length L
- Channel width W



Threshold Voltage, summary

 \Box If V_{SB} = 0 (no substrate bias):

$$V_{T0} = \Phi_{GC} - 2\phi_F - \frac{Q_{B0}}{C_{ox}} - \frac{Q_{ox}}{C_{ox}}$$

Remember: which factors are helping you (and which are obstructing) in reaching the inversion band diagram!!!

□ If $V_{SB} \neq 0$ (non-zero substrate bias)

$$V_T = V_{T0} + \gamma \left(\sqrt{\left| -2\phi_F + V_{SB} \right|} - \sqrt{\left| 2\phi_F \right|} \right)$$

Body effect (substrate-bias) coefficient:

 $\gamma = \frac{\sqrt{2qN_A}\mathcal{E}_{Si}}{C_{ox}} + \text{for NMOS} - \text{for PMOS}$

□ Threshold voltage increases as V_{SB} increases! (easy to explain with a band diagram...)

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Threshold Voltage (NMOS vs. PMOS)

	NMOS	PMOS
Substrate Fermi potential	$\phi_{F} < 0$	$\phi_{F} > 0$
Depletion charge density	Q _B < 0	Q _B > 0
Substrate bias coefficient	γ > 0	γ < 0
Substrate bias voltage	$V_{SB} > 0$	$V_{SB} < 0$
Threshold voltage (enhancement devices)	V _{T0} > 0	V _{T0} < 0

Remember: You need not memorize this table but rather should be able to fill it in based on the band diagrams...

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Threshold Voltage Adjustment

- Threshold voltage can be changed by doping the channel region with donor or acceptor ions
- □ For NMOS:
 - V_T increased by adding acceptor ions (p-type)
 - V_T decreased by adding donor ions (n-type)
 - Opposite for PMOS
- \Box Approximate change in V_{T0}:
 - Density of implanted ions = N₁ [cm⁻²]
 - Assume all implanted impurities are ionized

$$\Delta V_{T0} = \frac{qN_I}{C_{ox}}$$

Example: V_{T0} Adjustment

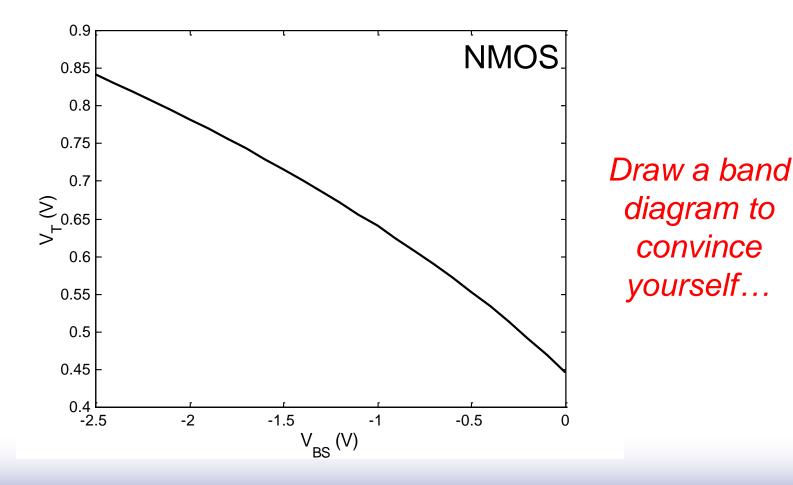
Consider an NMOS device:

- P-type substrate: $N_A = 2 \times 10^{16} \text{ cm}^{-3}$
- Polysilicon gate: $\Phi_{GC} = -0.92V$
- $t_{ox} = 600 \text{ Å} (1\text{ Å} = 1 \text{ x } 10^{-8} \text{ cm})$
- $N_{ox} = 2 \times 10^{10} \text{ cm}{-2}$
- $\epsilon_{Si} = 11.7 \epsilon_{0,} \epsilon_{ox} = 3.97 \epsilon_{0}$

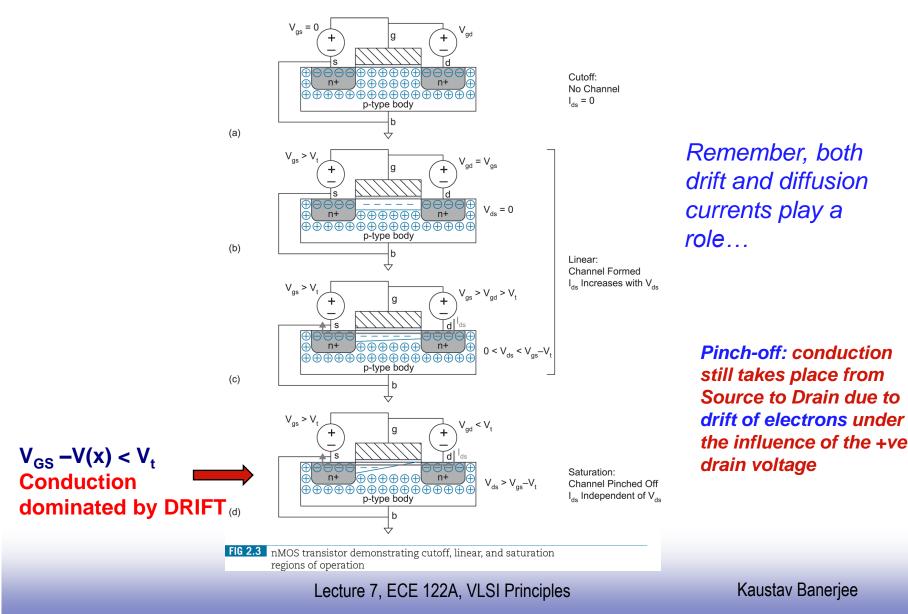
□ (a) Find V_{T0}

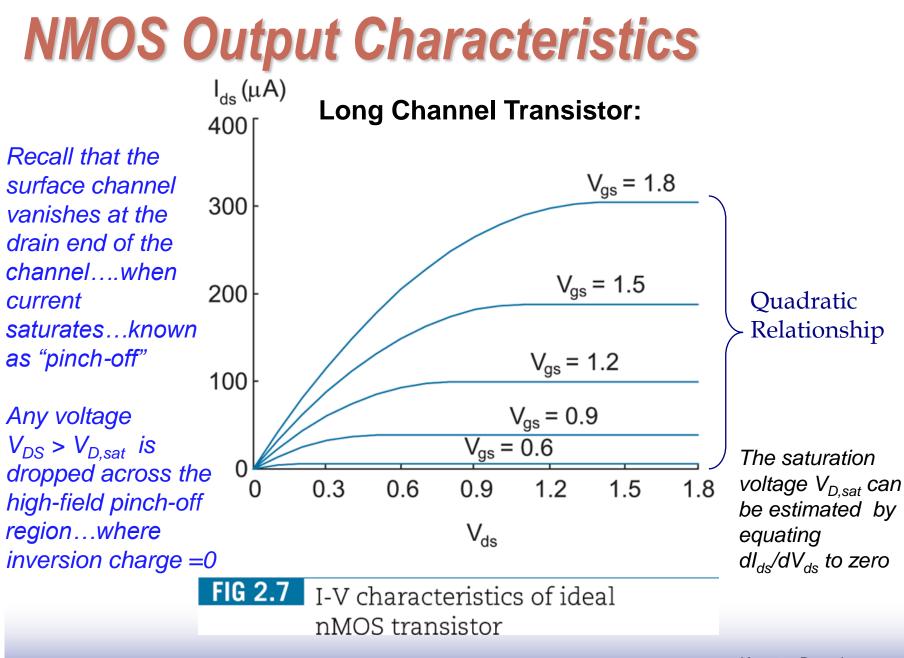
□ (b) Find amount and type of channel implant to get $V_{T0} = 0.4 \text{ V}$

The Body Effect



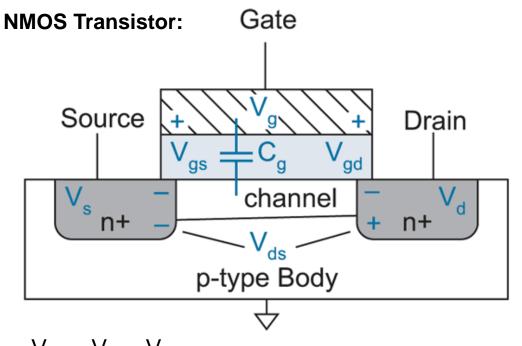
MOSFET Operation (NMOS)





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Channel Mobile Charge



Note: i) The inversion layer thickness is assumed to be zero: all charges are assumed to be located at the Si surface....like a sheet of charge.... ii) Hence, there is no potential drop or band bending across the inversion layer....

 $Q_{channel} = C_q \left(V_{qc} - V_t \right)$

$$V_{ds} = V_{gs} - V_{gd}$$

Average gate to channel potential:

$$V_{gc} = (V_{gs} + V_{gd})/2 = V_{gs} - V_{ds}/2$$

FIG 2.5 Average gate to channel voltage

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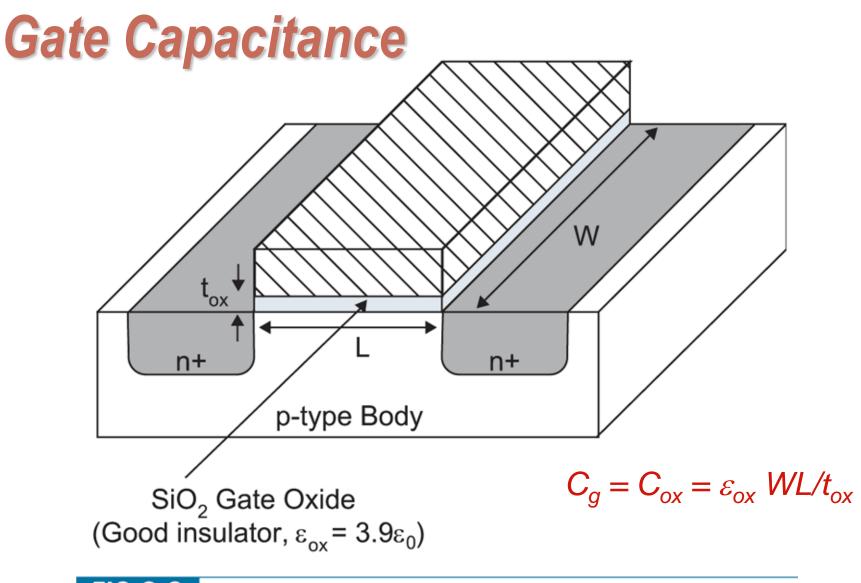


FIG 2.6 Transistor dimensions

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Transistor Currents (NMOS)

Cutoff Region:
$$I_{ds} = 0$$
, $V_{gs} < V_t$
Linear Region: $V_{gs} > V_t$, $V_{ds} < V_{gs} - V_t$
 $I_{ds} = W Q_{channel}$.carrier velocity(v)
 $I_{ds} = \mu C_{ox} W/L (V_{gs} - V_t - V_{ds}/2)V_{ds}$

Since Vds is small, Vds/2 can be neglected...and Ids is linearly proportional to Vds....like a resistor

Saturation Region:
$$V_{gs} > V_t$$
, $V_{ds} > V_{gs} - V_t$

Note: as Vds increases, average Q_{channel} decreases...

$$dI_{ds}/dV_{ds} = 0 at V_{ds} = V_{dsat} = V_{gs} - V_t$$

Substituting V_{ds} with V_{dsat} above: $I_{ds} = \beta/2 (V_{gs} - V_t)^2$

Note: for PMOS $V_{tp} = V_{tn}$ $\mu_p < \mu_n$, hence $(W/L)_{PMOS} \sim 2 (W/L)_{NMOS}$

$$Q_{channel} = C_g (V_{gc} - V_t)$$
$$V_{gc} = V_{gs} - V_{ds}/2)$$

$$v = \mu E$$

$$E_{lateral} = V_{ds}/L$$

$$\beta = \mu C_{ox} W/L$$

PMOS Transistor

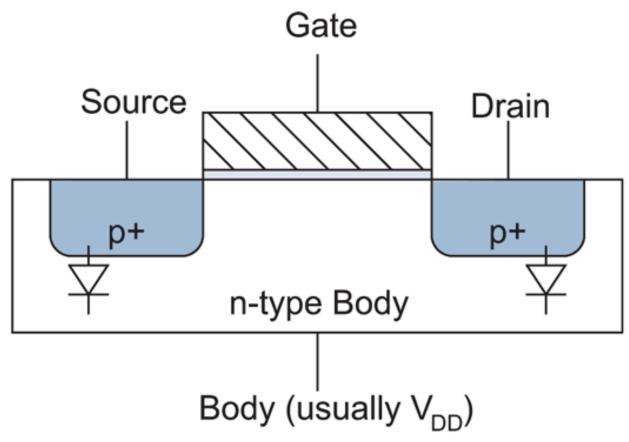


FIG 2.4 pMOS transistor

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PMOS Output Characteristics

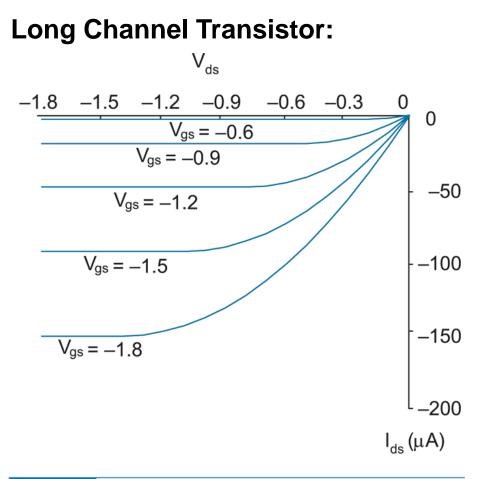


FIG 2.8 I-V characteristics of ideal pMOS transistor

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Channel Length Modulation

□ In saturation, pinch-off point moves

- As V_{DS} is increased, pinch-off point moves closer to source
- Effective channel length becomes shorter
- Current increases due to shorter channel

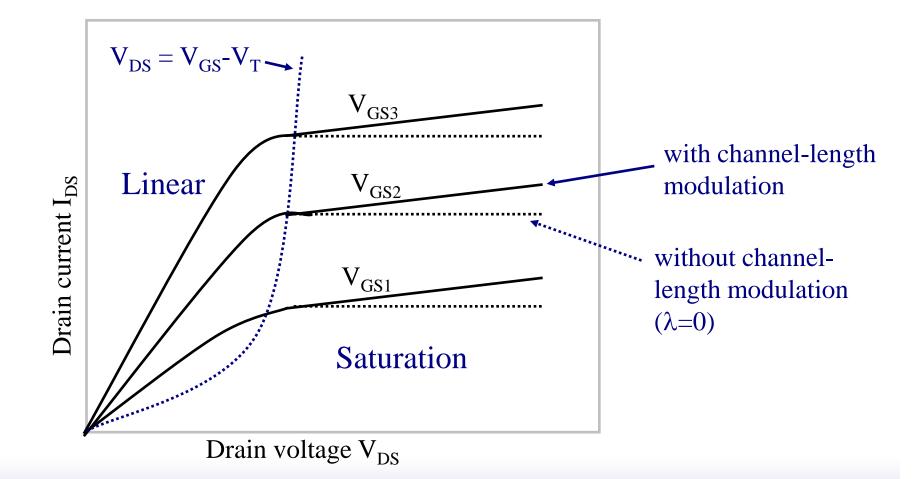
$$\dot{L} = L - \Delta L$$

$$I_{D} = \frac{1}{2} \mu_{n} C_{ox} \frac{W}{L} (V_{GS} - V_{TN})^{2} (1 + \lambda V_{DS})$$

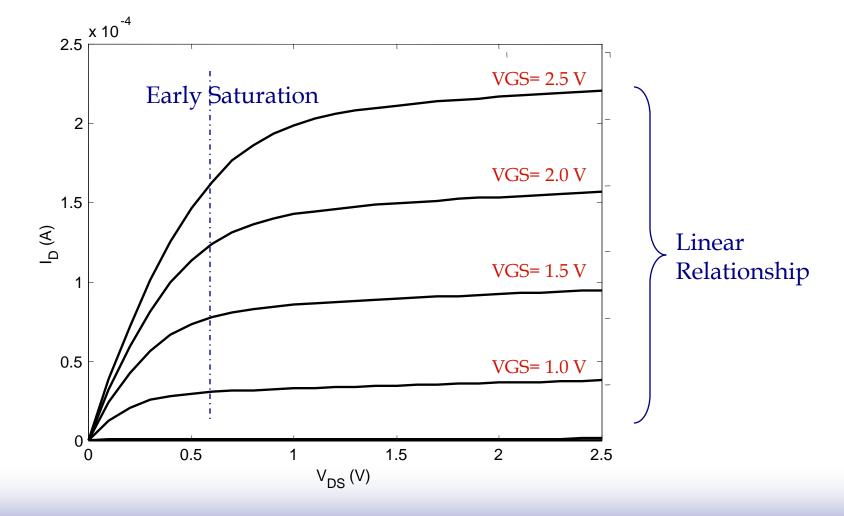
 λ = channel length modulation coefficient

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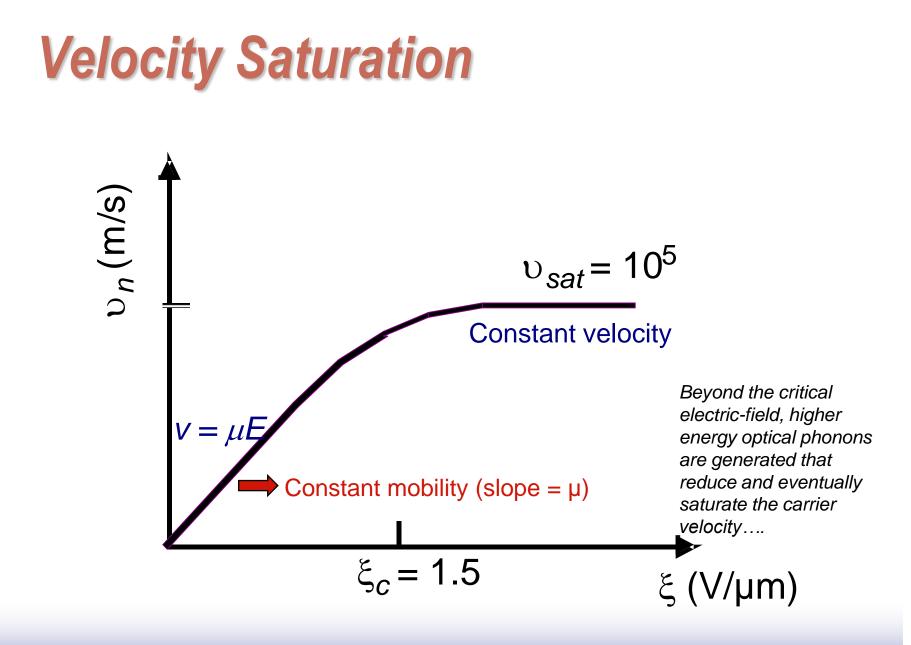
Summary: MOS Output I/V I/V curve for NMOS device:

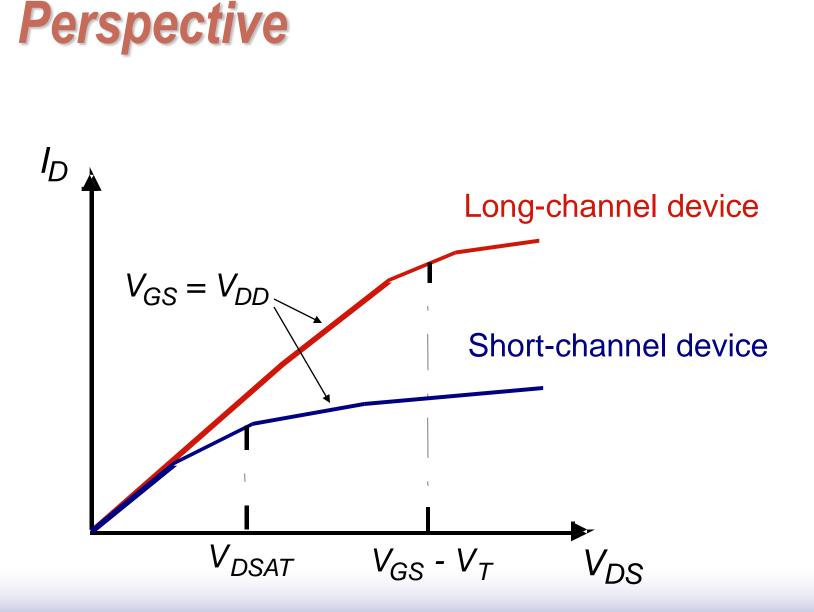


Current-Voltage Relations Short-Channel Transistors



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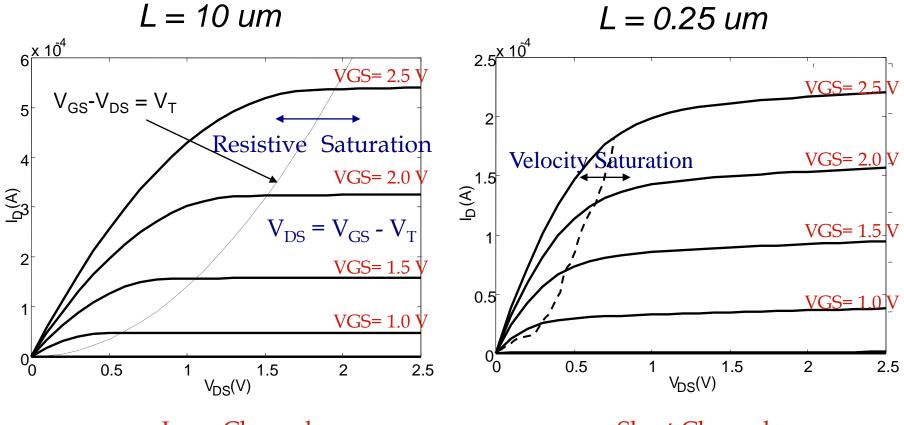




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Output Characteristics: I_D versus V_{DS}

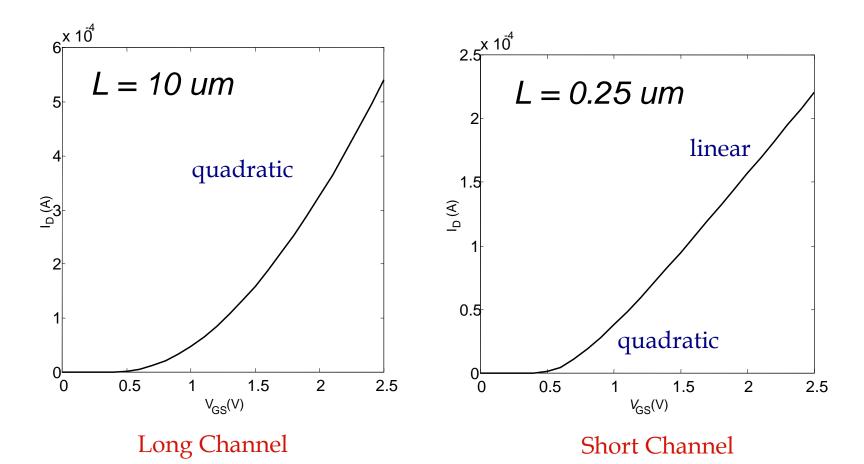
W/L = 1.5 for both cases....



Long Channel

Short Channel

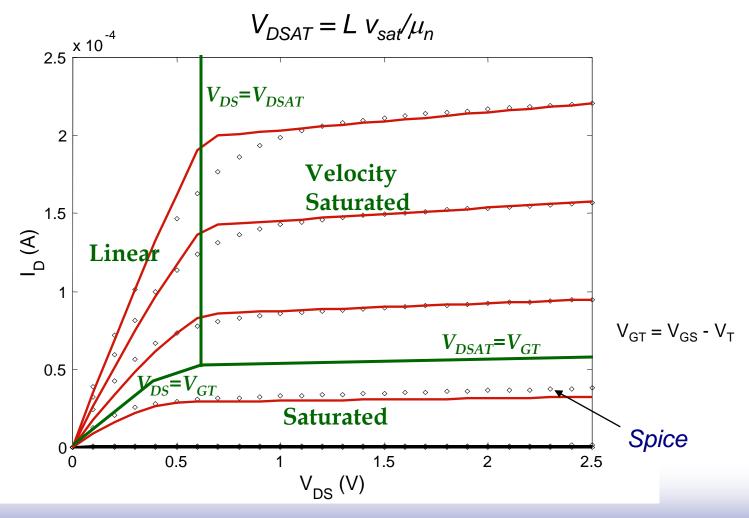
Input Characteristics: I_D versus V_{GS}



Note: These are Linear-Linear Plots!!

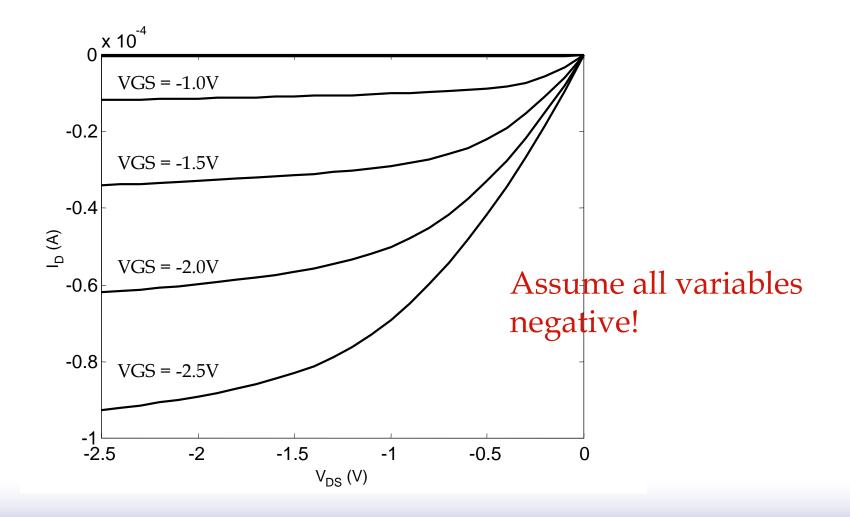
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Simple Model (solid lines) versus SPICE



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A PMOS Transistor (short-channel)



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Alpha-Power MOSFET Model

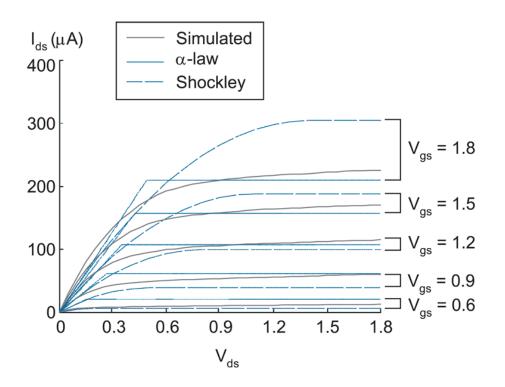


FIG 2.17 I-V characteristics for nMOS transistor with velocity saturation

Sakurai Model: $I_{ds} \propto (V_{gs} - V_t)^{\alpha}$

At low lateral E-fields, V_{ds}/L, current increases linearly with E-field

At high fields, E= E_{sat}

Carrier velocity saturates due to carrier scattering = v_{sat} (= μE_{sat})

 $I_{ds} = \mu C_{ox} W/L (V_{gs} - V_t)^2$ ---no velocity saturation

 $I_{ds} = C_{ox} W (V_{gs} - V_t) v_{sat}$

---complete velocity saturation

Practical situation: carrier velocity doesn't increase linearly with field but is not completely velocity saturated....

 $1 < \alpha < 2$, is the velocity saturation index, determined by curve fitting.....also accounts for mobility degradation due to high vertical field (V_{gs}/t_{ox})

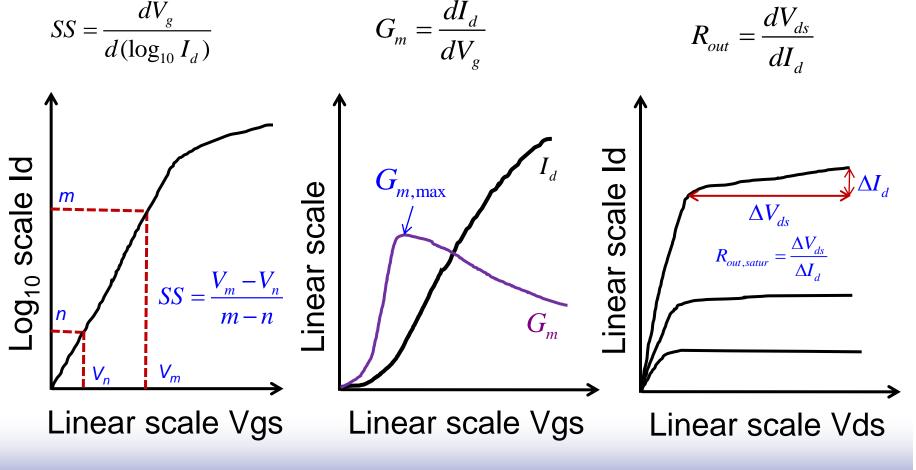
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How to Extract SS, G_m, and R_{out}

SS: Sub-threshold voltage swing

G_m: Transconductance

R_{out}: output resistance



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Methods to Extract Vth

